

Application/Control No.	Applicant(s)/Patent under Reexamination
10/665,444	SAWICKI ET AL.
Examiner	Art Unit
Quoc A. Tran	2176

	SEAR	CHED	
Class	Subclass	Date	Examiner
715	513	2/15/2006	
715	500	2/15/2006	1
345	853	2/15/2006	X
345	740	2/15/2006	$\sqrt{2}$
345	581	7/20/2006	1
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		')
	DATE	EXMR
USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB (see search history printout)	2/15/2006	8
IACM DataBase (see search history printout)	2/15/2006	8
USPAT, US-PGPUB, (see search history printout)	2/17/2006	
EAST (UAPAT, USPGPUB OCR EPO JPO DERWENT IBM_TOB) See Search History Printouit	7/1/2006	8